


<b>Search Notes</b>  	<b>Application/Control No.</b>  10533247	<b>Applicant(s)/Patent Under Reexamination</b>  JUNG, II-HYUNG
	<b>Examiner</b>  BINH K TIEU	<b>Art Unit</b>  2614

SEARCHED			
Class	Subclass	Date	Examiner
379	111, 112.06, 112.07, 112.08, 114.01, 114.03, 114.05, 114.06, 114.09, 114.12, 114.13, 114.18, 121.02, 127.05	06/06/2008	BKT
455	405-409	06/07/2008	BKT

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
379	114.01, 114.03, 114.09, 114.18, 121.02	06/07/2008	BKT